

April 2012

FDMS86101A

N-Channel PowerTrench® MOSFET 100 V, 60 A, 8 m Ω

Features

- Max $r_{DS(on)}$ = 8 m Ω at V_{GS} = 10 V, I_D = 13 A
- Max $r_{DS(on)}$ = 13.5 m Ω at V_{GS} = 6 V, I_D = 9.5 A
- \blacksquare Advanced Package and Silicon combination for low $r_{DS(on)}$ and high efficiency
- MSL1 robust package design
- 100% UIL tested
- 100% Rg tested
- RoHS Compliant

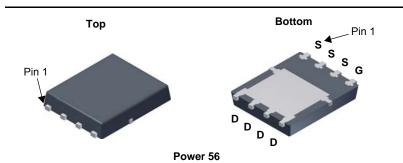
General Description

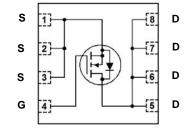
This N-Channel MOSFET is produced using Fairchild Semiconductor's advanced Power Trench® process thant has been especially tailored to minimize the on-state resistance and yet maintain superior switching performance.

Application

■ DC-DC Conversion







MOSFET Maximum Ratings T_A = 25 °C unless otherwise noted

Symbol	Parameter	Parameter			Units
V_{DS}	Drain to Source Voltage			100	V
V_{GS}	Gate to Source Voltage			±20	V
	Drain Current -Continuous (Package limited)	T _C = 25 °C		60	
I _D	-Continuous (Silicon limited) T _C = 25 °C			81	^
	-Continuous	T _A = 25 °C	(Note 1a)	13	A
	-Pulsed			180	
E _{AS}	Single Pulse Avalanche Energy		(Note 3)	486	mJ
В	Power Dissipation	T _C = 25 °C		104	W
P_{D}	Power Dissipation	T _A = 25 °C	(Note 1a)	2.5	VV
T _J , T _{STG}	Operating and Storage Junction Temperature Range			-55 to +150	°C

Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance, Junction to Case		1.2	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1a)	50	C/VV

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMS86101A	FDMS86101A	Power 56	13 "	12 mm	3000 units

Electrical Characteristics T_J = 25 °C unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Chara	acteristics					
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	100			V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I_D = 250 μ A, referenced to 25 °C		71		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 80 V, V _{GS} = 0 V			800	nA
I _{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$			±100	nA

On Characteristics

V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \mu A$	2.0	3.1	4.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I_D = 250 μA, referenced to 25 °C		-9		mV/°C
		V _{GS} = 10 V, I _D = 13 A		6.3	8	
r _{DS(on)}	Static Drain to Source On Resistance	$V_{GS} = 6 \text{ V}, I_D = 9.5 \text{ A}$		8.0	13.5	mΩ
` ,		$V_{GS} = 10 \text{ V}, I_D = 13 \text{ A}, T_J = 125 ^{\circ}\text{C}$		10.3	13.1	Ī
9 _{FS}	Forward Transconductance	V _{DS} = 10 V, I _D = 13 A		53		S

Dynamic Characteristics

C _{iss}	Input Capacitance			3095	4120	pF
C _{oss}	Output Capacitance	V _{DS} = 50 V, V _{GS} = 0 V, f = 1 MHz		460	615	pF
C _{rss}	Reverse Transfer Capacitance	1 - 1 101112		15	25	pF
R _g	Gate Resistance		0.1	1.6	3.3	Ω

Switching Characteristics

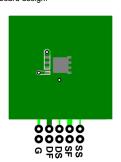
t _{d(on)}	Turn-On Delay Time		19	35	ns
t _r	Rise Time	V _{DD} = 50 V, I _D = 13 A,	5.4	11	ns
t _{d(off)}	Turn-Off Delay Time	V_{GS} = 10 V, R_{GEN} = 6 Ω	27	44	ns
t _f	Fall Time		4	10	ns
Qg	Total Gate Charge	V _{GS} = 0 V to 10 V	42	58	nC
Qg	Total Gate Charge	$V_{GS} = 0 \text{ V to 5 V} V_{DD} = 50 \text{ V},$	22	31	nC
Q _{gs}	Gate to Source Charge	I _D = 13 A	13.5		nC
Q _{gd}	Gate to Drain "Miller" Charge		6.2		nC

Drain-Source Diode Characteristics

\/	Vob Source to Drain Diode Forward voltage —	$V_{GS} = 0 \text{ V}, I_S = 2.1 \text{ A}$ (Note 2)		0.74	1.2	\/
v _{SD}		$V_{GS} = 0 \text{ V}, I_S = 13 \text{ A}$ (Note 2)		0.81	1.3	, v
t _{rr}	Reverse Recovery Time	I _E = 13 A, di/dt = 100 A/μs		64	102	ns
Q _{rr}	Reverse Recovery Charge	- 15 A, αι/αι – 100 A/μs		102	164	nC

Notes:

1. R_{0,D} is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R_{0,D} is guaranteed by design while R_{0,CA} is determined by the user's board design.



a. 50 °C/W when mounted on a 1 in² pad of 2 oz copper.



b. 125 °C/W when mounted on a minimum pad of 2 oz copper.

- 2. Pulse Test: Pulse Width < 300 μ s, Duty cycle < 2.0%.
- 3. E_{AS} 486 mJ is based on starting T_{J} = 25 °C, L = 3 mH, I_{AS} = 18 A, V_{DD} = 100 V, V_{GS} = 10 V. 100% test at L = 0.1 mH, I_{AS} = 51 A.

Typical Characteristics T_{.1} = 25 °C unless otherwise noted

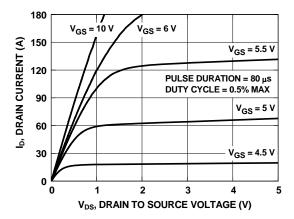


Figure 1. On-Region Characteristics

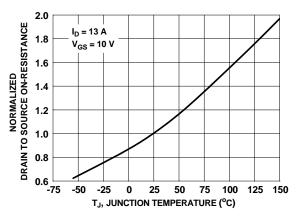


Figure 3. Normalized On-Resistance vs Junction Temperature

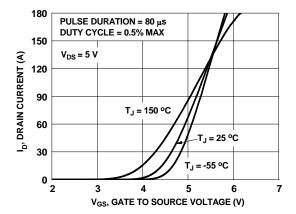


Figure 5. Transfer Characteristics

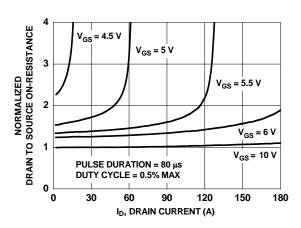


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

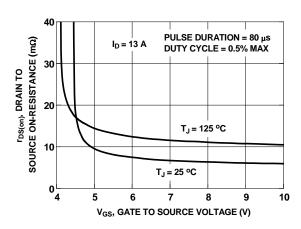


Figure 4. On-Resistance vs Gate to Source Voltage

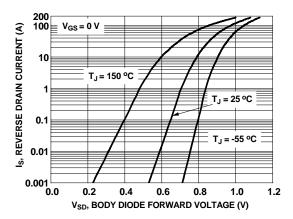


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics T_J = 25 $^{\circ}$ C unless otherwise noted

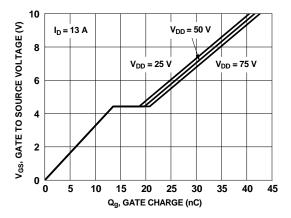


Figure 7. Gate Charge Characteristics

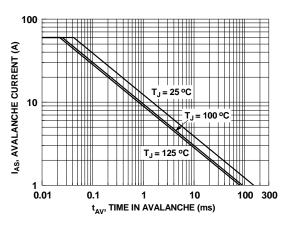


Figure 9. Unclamped Inductive Switching Capability

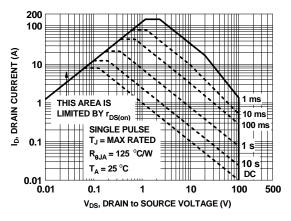


Figure 11. Forward Bias Safe Operating Area

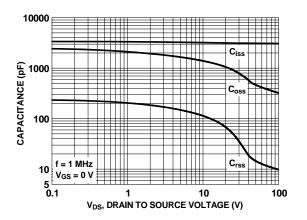


Figure 8. Capacitance vs Drain to Source Voltage

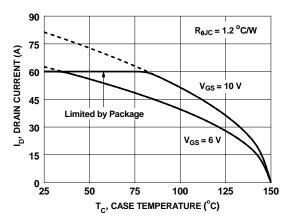


Figure 10. Maximum Continuous Drain Current vs Case Temperature

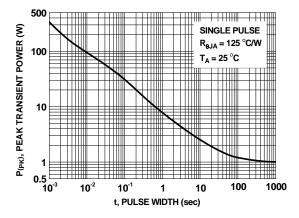


Figure 12. Single Pulse Maximum Power Dissipation



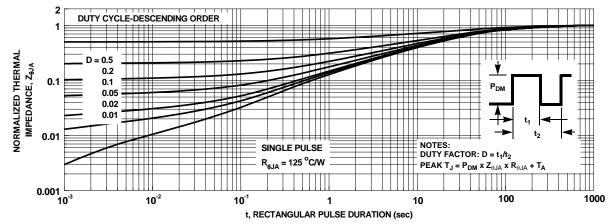


Figure 13. Junction-to-Ambient Transient Thermal Response Curve

Dimensional Outline and Pad Layout A PKG В 8 5 0.77 4.52 KEEP OUT AREA 3.75 PKG & 6.61 0 PIN #1 **IDENT MAY** TOP VIEW APPEAR AS 3 OPTIONAL 0.61 1.27 SEE DETAIL A LAND PATTERN RECOMMENDATION SIDE VIEW **OPTIONAL DRAFT** ANGLE MAY APPEAR ON FOUR SIDES 5.10 4.90 3.81 OF THE PACKAGE 1.27 0.46 0.36 (8X) (0.39)⊕ 0.10M C A B 3 4 _[(0.52) 0.71_ 0.44 6.25 5.90 (0.50) **CHAMFER** (3.40)CORNER (1.81) AS PIN #1 IDENT MAY APPEAR AS OPTIONAL - 0.15 MAX (2X) 6 OPTION - B (PUNCHED TYPE) 0.71 0.44 NOTES: UNLESS OTHERWISE SPECIFIED A) PACKAGE STANDARD REFERENCE: **BOTTOM VIEW** JEDEC MO-240, ISSUE A, VAR. AA, DATED OCTOBER 2002. B) ALL DIMENSIONS ARE IN MILLIMETERS. C) DIMENSIONS DO NOT INCLUDE BURRS // 0.10 C OR MOLD FLASH. MOLD FLASH OR BURRS DOES NOT EXCEED 0.10MM. D) DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994. E) IT IS RECOMMENDED TO HAVE NO TRACES 0.08 C C 0.30 0.05 OR VIAS WITHIN THE KEEP OUT AREA. F) DRAWING FILE NAME: PQFN08AREV6. **SEATING PLANE** DETAIL A SCALE: 2:1 OPTION - A (SAWN TYPE)





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Rev. 161